

TANCERAM® chip capacitors can replace tantalum capacitors in many applications and offer several key advantages over traditional tantalums. Because TANCERAM® capacitors exhibit extremely low ESR, equivalent circuit performance can often be achieved using considerably lower capacitance values. Low DC leakage reduces current drain, extending the battery life of portable products. TANCERAM® high DC breakdown voltage ratings offer improved reliability and eliminate large voltage de-rating common when designing with tantalums.

ADVANTAGES

- Low ESR
- Higher Surge Voltage

100%

75%

50%

25%

0%

0

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Distribution

28

- Reduced CHIP Size
- Low DC Leakage
- Non-polarized Devices
- Improved Reliability

Typical Breakdown Voltage Comparison

1.0 µF / 16V TANCERAM

DC Breakdown Voltage

300

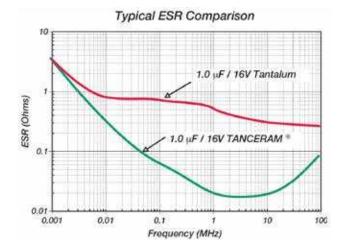
1.0 µF / 16V Tantalum

200

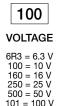
- Higher Insulation Resistance
 Higher Ripple Current

APPLICATIONS

- Switching Power Supply Smoothing (Input/Output) •
- DC/DC Converter Smoothing (Input/Output)
- Backlighting Inverters
- General Digital Circuits



How to Order TANCERAM®



Х R15 DIELECTRIC SIZE See Chart





106

CAPACITANCE 1st two digits are significant; third digit



TOLERANCE TERMINATION V = Nickel Barrier $K = \pm 10\%$ with 100% Tin $M = \pm 20\%$

100



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Part number written: 100R15X106MV4E

4

400



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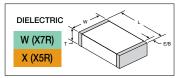
PACKING

500



www.johansondielectrics.com





CASE SIZE

CAPACITANCE SELECTION

$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		EIA / JDI	INCHES	(mm)	VDC	1.0	μF	2.2	μF	3.3	μF	4.7	μF	10	μF	22	μF	47	μF	100	μF
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	-		W .020 ±.004 T .025 Max.	(0.51 ±.10) (0.64)	10																
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			W .032 ±.008 T .035 Max.	(0.81 ±.20) (0.89)	16 10																
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			W .050 ±.010 T .060 Max.	(1.27 ±.25) (1.52)	25 16 10																
$\begin{array}{c c c c c c c c c c c c c c c c c c c $			W .062 ±.010 T .070 Max.	(1.57 ±.25) (1.78)	100 50 35 25 16 10																
1812 L .177 ±.016 (4.50 ±.40) 50 25 26 <td></td> <th></th> <td>W .098 ±.012 T .110 Max.</td> <td>(2.50 ±.30) (2.8)</td> <td>50 35 25 16 10</td> <td></td>			W .098 ±.012 T .110 Max.	(2.50 ±.30) (2.8)	50 35 25 16 10																
			W .126 ±.015 T .140 Max.	(3.20 ±.38) (3.55)	100 50 25 16																

ELECTRICAL CHARACTERISTICS

DIELECTRIC:	X7R	X5R						
TEMPERATURE COEFFICIENT:	±15% (-55 to +125°C)	±15% (-55 to +85°C)						
DISSIPATION FACTOR:	For \ge 50 VDC: 5% max. For \le 35 VDC: 10% max.	For \ge 50 VDC: 5% max. For \le 35 VDC: 10% max.						
INSULATION RESISTANCE (MIN. @ 25°C, WVDC)	100 ΩF or 10 G\Omega, whichever is less							
DIELECTRIC STRENGTH:	2.5 X WVDC, 25°C, 50mA max.							
TEST CONDITIONS:	Capacitance values \leq 10 µF: 1.0kHz±50Hz @ 1.0±0.2 Vrms Capacitance values > 10 µF: 120Hz±10Hz @ 0.5V±0.1 Vrms							
OTHER:	See page 35 for additional dielectric specifications.							

